Notice of References Cited Application/Control No. 10/640,558 Applicant(s)/Patent Under Reexamination VAN DUYN, PAUL D. Examiner Jacob Y. Choi Applicant(s)/Patent Under Reexamination VAN DUYN, PAUL D. Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,803,593	09-1998	Siminovitch et al.	362/304
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